Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
10/092,452	RUCKART, JOHN P.
Examiner	Art Unit
Wen W. Huang	2618

SEARCHED				
Class	Subclass	Date	Examiner	
455	556.1	8/4/2004	WH	
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	463			
	464			
	412.1			
379	67.1			
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above	UPDATED	4/5/2005	WH	
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above	UPDATED	7/24/2006	WH	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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	DATE	EXMR
Lee Nguyen (455)	8/4/2004	WH
Benny Tieu (379)	8/4/2004	WH
East text search	8/4/2004	WH
above UPDATED	4/5/2005	WH
above UPDATED	1/10/2006	WH
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